



SCOPE OF ACCREDITATION TO ISO/IEC 17025:2005,
ANSI/NCSL Z540-1-1994 & ANSI/NCSL Z540.3-2006

TRESCAL, INC.
47 Loveton Circle Suite I
Sparks, MD 21256
Bryan Wilkerson Phone: 410 337 0687

CALIBRATION

Valid To: December 31, 2019

Certificate Number: 1346.01

In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform the following calibrations¹:

I. Chemical

Parameter/Equipment	Range	CMC ² (±)	Comments
pH – Measuring Equipment ^{3,7}	(4, 7, 10) pH	0.016 pH	Buffer solutions
Electrolytic Conductivity – Measuring Equipment ^{3,7}	≈10 μS/cm ≈100 μS/cm ≈1000 μS/cm ≈10 000 μS/cm	0.53 μS/cm 2.4 μS/cm 23 μS/cm 0.23 mS/cm	Conductivity solutions

II. Dimensional

Parameter/Equipment	Range	CMC ² (±)	Comments
Angle ³ – Measure & Measuring Equipment	Up to 60°	5.8”	Sine bar/plate w/ gage blocks

Parameter/Equipment	Range	CMC ^{2,4,6} (\pm)	Comments
Bore Gages – Bore Micrometer, Bore Indicators, Air Gage Systems	Up to 6 in	$(0.7R + 4L) \mu\text{in}$	Plain cylindrical ring gages
Gage Blocks	Up to 4 in (5 to 20) in	$(1.8 + 1.9L) \mu\text{in}$ $(4.6 + 1.8L) \mu\text{in}$	Gage blocks, gage block comparator
Hand Tools ^{3,7} – Indicators Micrometers Depth Gages Height Gages Calipers	Up to 1 in (1 to 6) in (1 to 72) in (1 to 72) in (1 to 72) in (1 to 120) in	$2.7 \mu\text{in/in} + 5.1 \mu\text{in}$	Gage blocks
Height Master	Up to 24 in	$(39 + 6.7L) \mu\text{in}$	Gage blocks w/ electronic amplifier
Length Standards – Micrometer, Gaging Fixtures-Single Axis, Others	Up to 48 in	$(10 + 8L) \mu\text{in}$	Gage blocks, electronic indicator, UMM
Optical Comparators ³ – X or Y X & Y	8 in or 4 in 8 in by 4 in	$0.06 \% + 0.00035 \text{ in}$ $0.085 \% + 0.00049 \text{ in}$	
Plain Cylindrical Plug Gages, Pin Gages	Up to 10 in	$(1.8 + 7.4L) \mu\text{in}$	UMM, gage blocks
Plain Cylindrical Ring Gages	(0.125 to 10) in	$(1 + 7.5D) \mu\text{in}$	UMM, gage blocks

Parameter/Equipment	Range	CMC ^{2,4} (±)	Comments
Thread Plugs – Simple Pitch Diameter Major Diameter	Up to 10 in Up to 10 in	$(70 + 3.9D) \mu\text{in}$ $(38 + 5.3D) \mu\text{in}$	UMM, thread wires, gage blocks
Thread Rings (Adjustable)	Up to 4 in	0.00023 in	Class X thread setting plugs
NPT Plugs – Simple Pitch Diameter Step	Up to 3 in	$(70 + 2D) \mu\text{in}$ 160 μin	UMM, thread wires, sine block, indicator
NPT Rings – Pitch Diameter (Standoff) Thickness	Up to 3 in	250 μin 150 μin	NPT master plugs Indicator

III. Dimensional Inspection

Parameter/Equipment	Range	CMC ^{2,6} (±)	Comments
Length ⁸ – 1D 2D	Up to 8 in Up to 8 in x 4 in	0.06 % + 350 μin 0.085 % + 490 μin	Optical comparator

IV. Electrical – DC/Low Frequency

Parameter/Equipment	Range	CMC ^{2,5} (±)	Comments
DC Voltage ^{3,7} – Measure	Up to 100 mV (0.1 to 1) V (1 to 10) V (10 to 100) V (100 to 1000) V	10 $\mu\text{V}/\text{V} + 0.37 \mu\text{V}$ 6.1 $\mu\text{V}/\text{V} + 0.37 \mu\text{V}$ 5.8 $\mu\text{V}/\text{V} + 0.59 \mu\text{V}$ 8.7 $\mu\text{V}/\text{V} + 37 \mu\text{V}$ 8.7 $\mu\text{V}/\text{V} + 0.12 \text{ mV}$	Agilent 3458A
DC Voltage ^{3,7} – Generate	(0 to 220) mV (0.22 to 2.2) V (2.2 to 11) V (11 to 22) V (22 to 220) V (220 to 1100) V	6.8 $\mu\text{V}/\text{V} + 0.4 \mu\text{V}$ 3.7 $\mu\text{V}/\text{V} + 0.7 \mu\text{V}$ 4.9 $\mu\text{V}/\text{V} + 2.9 \mu\text{V}$ 4.9 $\mu\text{V}/\text{V} + 4.3 \mu\text{V}$ 3.7 $\mu\text{V}/\text{V} + 48 \mu\text{V}$ 4.7 $\mu\text{V}/\text{V} + 0.48 \text{ mV}$	Fluke 5720A w/ 5725A
DC Current ^{3,7} – Generate	0.1 nA to 220 μA (0.22 to 2.2) mA (2.2 to 22) mA (22 to 220) mA (0.22 to 2.2) A (2.2 to 11) A (11 to 20.5) A (20 to 150) A (150 to 1000) A	35 $\mu\text{A}/\text{A} + 6 \text{ nA}$ 31 $\mu\text{A}/\text{A} + 7 \text{ nA}$ 30 $\mu\text{A}/\text{A} + 41 \text{ nA}$ 41 $\mu\text{A}/\text{A} + 0.70 \mu\text{A}$ 77 $\mu\text{A}/\text{A} + 12 \mu\text{A}$ 0.034 % + 0.48 mA 0.10 % + 0.90 mA 0.59 % + 0.16 A 0.59 % + 0.58 A	Fluke 5720A w/ 5725A Fluke 5522A Fluke 5500A/coil
DC Current ^{3,7} – Measure	Up to 100 μA (0.1 to 1) mA (1 to 10) mA (10 to 100) mA (0.1 to 1) A (1 to 10) A (10 to 100) A (30 to 300) A (300 to 1200) A	17 $\mu\text{A}/\text{A} + 0.80 \text{ nA}$ 17 $\mu\text{A}/\text{A} + 5 \text{ nA}$ 17 $\mu\text{A}/\text{A} + 50 \text{ nA}$ 31 $\mu\text{A}/\text{A} + 0.5 \mu\text{A}$ 0.010 % + 10 μA 0.31 mA 33 $\mu\text{A}/\text{A}$ 56 $\mu\text{A}/\text{A}$ 0.051 %	Agilent 3458A w/ L&N 4222 w/ L&N 4361 w/ L&N 4363 w/ RAM shunt



Parameter/Equipment	Range	CMC ^{2,5} (±)	Comments
DC Resistance ^{3,7} – Generate, Fixed Points	0 Ω 1 Ω 1.9 Ω 10 Ω 19 Ω 100 Ω 190 Ω 1 kΩ 1.9 kΩ 10 kΩ 19 kΩ 100 kΩ 190 kΩ 1 MΩ 1.9 MΩ 10 MΩ 19 MΩ 100 MΩ	40 μΩ 95 μΩ 0.18 mΩ 0.26 mΩ 0.49 mΩ 1.2 mΩ 2.5 mΩ 10 mΩ 19 mΩ 0.10 Ω 0.19 Ω 1.3 Ω 2.5 Ω 21 Ω 42 Ω 0.40 kΩ 0.93 kΩ 13 kΩ	Fluke 5720A
DC Resistance ^{3,7} – Generate, Fixed Points	0.001 Ω 0.01 Ω 0.1 Ω 1 Ω 10 kΩ 100 MΩ 1 GΩ 10 GΩ 100 GΩ	90 μΩ/Ω 94 μΩ/Ω 84 μΩ/Ω 2.5 μΩ 2.4 μΩ 0.18 % 0.64 % 0.70 % 0.74 %	L&N 4015-B Fluke 742A-1 Fluke 742A-10K IET HRRS-B-5-1M



Parameter/Equipment	Range	CMC ^{2,5} (\pm)	Comments
Resistance ^{3,7} – Generate	Up to 10.99 Ω (11 to 32.999) Ω (33 to 109.9999) Ω (110 to 329.9999) Ω 330 Ω to 1.099999 k Ω (1.1 to 3.299999) k Ω (3.3 to 10.99999) k Ω (11 to 32.99999) k Ω (33 to 109.9999) k Ω (110 to 329.9999) k Ω	40 $\mu\Omega/\Omega$ + 1.0 m Ω 30 $\mu\Omega/\Omega$ + 1.5 m Ω 28 $\mu\Omega/\Omega$ + 1.4 m Ω 28 $\mu\Omega/\Omega$ + 2.0 m Ω 28 $\mu\Omega/\Omega$ + 2.0 m Ω 28 $\mu\Omega/\Omega$ + 20 m Ω 28 $\mu\Omega/\Omega$ + 20 m Ω 28 $\mu\Omega/\Omega$ + 0.21 Ω 28 $\mu\Omega/\Omega$ + 0.21 Ω 32 $\mu\Omega/\Omega$ + 2.0 Ω	Fluke 5522A, 4-wire
	330 k Ω to 1.09999 M Ω (1.1 to 3.29999) M Ω (3.3 to 10.9999) M Ω (11 to 32.9999) M Ω (33 to 109.9999) M Ω (110 to 329.999) M Ω (330 to 1100) M Ω	32 $\mu\Omega/\Omega$ + 2.1 Ω 60 $\mu\Omega/\Omega$ + 30 Ω 0.013 % + 50 Ω 0.025 % + 2.5 k Ω 0.050 % + 3.0 k Ω 0.30 % + 0.10 M Ω 1.5 % + 0.50 M Ω	Fluke 5522A, 2-wire
Resistance ⁷ – Measure	(0.1 to 1) Ω (1 to 1.9) Ω (1.9 to 10) Ω (10 to 100) Ω (0.1 to 1) k Ω (1 to 10) k Ω (10 to 19) k Ω (19 to 100) k Ω (0.1 to 1) M Ω (1 to 10) M Ω (10 to 19) M Ω (19 to 100) M Ω	60 $\mu\Omega/\Omega$ 16 $\mu\Omega/\Omega$ 13 $\mu\Omega/\Omega$ 14 $\mu\Omega/\Omega$ 14 $\mu\Omega/\Omega$ 4.8 $\mu\Omega/\Omega$ 4.8 $\mu\Omega/\Omega$ 4.9 $\mu\Omega/\Omega$ 7.3 $\mu\Omega/\Omega$ 10 $\mu\Omega/\Omega$ 13 $\mu\Omega/\Omega$ 20 $\mu\Omega/\Omega$	Fluke 5700A, Agilent 3458A and 742A series resistors



Parameter/Equipment	Range	CMC ^{2,5} (±)	Comments
Resistance ^{3,7} – Measure	(0 to 1) Ω (1 to 10) Ω (10 to 100) Ω (100 to 1000) Ω (1 to 10) kΩ (10 to 100) kΩ (100 to 1000) kΩ (1 to 10) MΩ (10 to 100) MΩ (0.1 to 1) GΩ	82 μΩ/Ω + 2.4 μΩ 17 μΩ/Ω + 58 μΩ 12 μΩ/Ω + 0.58 mΩ 9.4 μΩ/Ω + 0.58 mΩ 9.5 μΩ/Ω + 5.8 mΩ 9.7 μΩ/Ω + 58 mΩ 15 μΩ/Ω + 2.3 Ω 58 μΩ/Ω + 0.12 kΩ 0.058 % + 1.2 kΩ 0.6 % + 12 kΩ	Agilent 34420A, Agilent 3458A

Parameter/Range	Frequency	CMC ^{2,5} (±)	Comments
AC Voltage ^{3,7} – Generate			
Up to 2.2 mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz (1 to 10) MHz (10 to 20) MHz (20 to 30) MHz	0.022 % + 4 μV 0.009 % + 4 μV 0.008 % + 4 μV 0.018 % + 4 μV 0.046 % + 5 μV 0.09 % + 10 μV 0.12 % + 20 μV 0.25 % + 20 μV 0.30 % + 3 μV 0.50 % + 3 μV 1.5 % + 3 μV	Fluke 5720A
(2.2 to 22) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz (1 to 10) MHz (10 to 20) MHz (20 to 30) MHz	0.022 % + 4 μV 0.009 % + 4 μV 0.008 % + 4 μV 0.018 % + 4 μV 0.046 % + 5 μV 0.090 % + 10 μV 0.12 % + 20 μV 0.25 % + 20 μV 0.20 % + 3 μV 0.40 % + 3 μV 1.0 % + 3 μV	



Parameter/Range	Frequency	CMC ^{2,5} (\pm)	Comments
AC Voltage ^{3,7} – Generate (cont)			
(22 to 220) mV	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz (1 to 10) MHz (10 to 20) MHz (20 to 30) MHz	0.022 % + 12 μ V 0.009 % + 7 μ V 0.008 % + 7 μ V 0.018 % + 7 μ V 0.042 % + 17 μ V 0.075 % + 20 μ V 0.12 % + 25 μ V 0.25 % + 45 μ V 0.20 % + 3.0 μ V 0.40 % + 3.0 μ V 1.0 % + 3.0 μ V	Fluke 5720A
(0.22 to 2.2) V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz (1 to 10) MHz (10 to 20) MHz (20 to 30) MHz	0.022 % + 40 μ V 0.009 % + 15 μ V 0.004 % + 8.0 μ V 0.007 % + 10 μ V 0.011 % + 30 μ V 0.034 % + 80 μ V 0.090 % + 0.20 mV 0.15 % + 0.30 mV 0.20 % + 6.5 μ V 0.40 % + 6.5 μ V 1.0 % + 6.5 μ V	
(2.2 to 22) V	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.022 % + 0.40 mV 0.008 % + 0.15 mV 0.004 % + 0.05 mV 0.007 % + 0.10 mV 0.010 % + 0.20 mV 0.026 % + 0.6 mV 0.090 % + 2.0 mV 0.13 % + 3.2 mV	
(22 to 220) V*	(10 to 20) Hz (20 to 40) Hz 40 Hz to 20 kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.022 % + 4.0 mV 0.008 % + 1.5 mV 0.005 % + 0.60 mV 0.008 % + 1.0 mV 0.013 % + 2.5 mV 0.080 % + 16 mV 0.42 % + 40 mV 0.70 % + 80 mV	*220 V range subject to 2.2E7 V-Hz limitation

Parameter/Range	Frequency	CMC ^{2,5} (±)	Comments
AC Voltage ^{3,7} – Generate (cont)			
(220 to 1100) V	(15 to 50) Hz 50 Hz to 1 kHz	0.026 % + 16 mV 0.006 % + 3.5 mV	Fluke 5720A
(220 to 750) V	(1 to 20) kHz (20 to 30) kHz (30 to 50) kHz (50 to 100) kHz	0.013 % + 6.0 mV 0.036 % + 11 mV 0.036 % + 11 mV 0.13 % + 45 mV	
AC Voltage ^{3,7} – Measure			
(0.1 to 10) mV	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz	0.030 % + 3.3 μV 0.020 % + 1.8 μV 0.030 % + 1.8 μV 0.10 % + 1.8 μV 0.50 % + 1.8 μV 4.0 % + 1.8 μV	Agilent 3458A
(10 to 100) mV	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (0.3 to 1) MHz (1 to 2) MHz	0.007 % + 10 μV 0.007 % + 2 μV 0.014 % + 2 μV 0.030 % + 2 μV 0.080 % + 2 μV 0.30 % + 10 μV 1.0 % + 10 μV 1.5 % + 10 μV	
100 mV to 1V	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (0.3 to 1) MHz (1 to 2) MHz	0.007 % + 40 μV 0.007 % + 20 μV 0.014 % + 20 μV 0.030 % + 20 μV 0.080 % + 20 μV 0.30 % + 0.10 mV 1.0 % + 0.10 mV 1.5 % + 0.10 mV	
(1 to 10) V	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (0.3 to 1) MHz (1 to 2) MHz	0.007 % + 0.40 mV 0.007 % + 0.20 mV 0.014 % + 0.20 mV 0.030 % + 0.20 mV 0.080 % + 0.20 mV 0.30 % + 1.0 mV 1.0 % + 1.0 mV 1.5 % + 1.0 mV	



Parameter/Range	Frequency	CMC ^{2,5} (\pm)	Comments
AC Voltage ^{3,7} – Measure (cont)			
(10 to 100) V	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (0.3 to 1) MHz	0.02 % + 4.0 mV 0.02 % + 2.0 mV 0.02 % + 2.0 mV 0.04 % + 2.0 mV 0.12 % + 2.0 mV 0.40 % + 10 mV 1.5 % + 10 mV	Agilent 3458A
(100 to 707) V	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz	0.04 % + 40 mV 0.04 % + 20 mV 0.06 % + 20 mV 0.12 % + 20 mV 0.30 % + 20 mV	
AC Current – Generate ^{3,7}			
Up to 220 μ A	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.023 % + 16 nA 0.014 % + 10 nA 0.011 % + 8.0 nA 0.025 % + 12 nA 0.090 % + 65 nA	Fluke 5720A w/ 5725A
(0.22 to 2.2) mA	(10 to 30) kHz	1.6 % + 0.40 μ A	Fluke 5522A
	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.023 % + 41 nA 0.014 % + 36 nA 0.011 % + 36 nA 0.025 % + 0.11 μ A 0.090 % + 0.65 μ A	Fluke 5720A w/ 5725A
(2.2 to 22) mA	(10 to 30) kHz	1.0 % + 0.60 μ A	Fluke 5522A
	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	0.023 % + 0.40 μ A 0.014 % + 0.36 μ A 0.011 % + 0.36 μ A 0.025 % + 0.56 μ A 0.090 % + 5.0 μ A 0.40 % + 4.0 μ A	Fluke 5720A w/ 5725A Fluke 5522A

Parameter/Range	Frequency	CMC ^{2,5} (±)	Comments
AC Current ^{3,7} – Generate (cont)			
(22 to 220) mA	(10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	0.023 % + 4.1 µA 0.014 % + 3.6 µA 0.011 % + 2.6 µA 0.018 % + 3.6 µA 0.090 % + 10 µA 0.40 % + 0.20 mA	Fluke 5720A w/ 5725A Fluke 5522A
(0.22 to 2.2) A	20 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.024 % + 36 µA 0.039 % + 80 µA 0.60 % + 0.16 mA	Fluke 5720A w/ 5725A
(2.2 to 11) A	40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.040 % + 0.18 mA 0.085 % + 0.39 mA 0.33 % + 0.75 mA	Fluke 5720A w/ 5725A
(11 to 20.5) A	(45 to 100) Hz 100 Hz to 1 kHz (1 to 5) kHz	0.12 % + 5.1 mA 0.15 % + 5.1 mA 3.0 % + 5.1 mA	Fluke 5522A
(16.5 to 150) A	(45 to 65) Hz (65 to 440) Hz	0.38 % + 0.029 A 1.0 % + 0.031 A	Fluke 5522A w/ Fluke 5500A coil
(150 to 1025) A	(45 to 65) Hz (65 to 440) Hz	1.0 % + 0.031 A 1.0 % + 0.12 A	
AC Current – Measure ^{3,7}			
(5 to 100) µA	(10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz	0.40 % + 0.03 µA 0.15 % + 0.03 µA 0.061 % + 0.03 µA	Agilent 3458A
(0.1 to 100) mA	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz (0.1 to 5) kHz	0.40 % + 0.02 % rng 0.15 % + 0.02 % rng 0.061 % + 0.02 % rng 0.031 % + 0.02 % rng	
(0.1 to 1) A	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz (0.1 to 5) kHz	0.40 % + 0.2 mA 0.16 % + 0.2 mA 0.081 % + 0.2 mA 0.10 % + 0.2 mA	
100 mA to 20 A	Up to 1 kHz (1 to 5) kHz	0.039 % + 0.032 %*F 0.041 % + 0.032 %*F	Agilent 3458A w/ Fluke Y5020; <i>F</i> is the applied frequency

Parameter/Range	Frequency	CMC ^{2,6} (±)	Comments
Capacitance ^{3,7} – Generate, Fixed Points 100 pF to 1.1 μF	1 kHz	0.03 %	GenRad 1423-A
Capacitance ^{3,7} – Measure 50 pF to 1 μF	120 Hz, 1 kHz	0.24 % + 0.19 pF	GenRad 1657
Inductance ^{3,7} – Measure 10 μH to 10 H	120 Hz, 1 kHz	0.25 %	GenRad 1657

Parameter/Equipment	Range	CMC ² (±)	Comments
Electrical Calibration of RTDs ³ Indicating Systems & Measure – Pt 385, 100 Ω	(-200 to 80) °C (-80 to 100) °C (100 to 300) °C (300 to 400) °C (400 to 600) °C (600 to 800) °C	0.013 °C 0.02 °C 0.024 °C 0.026 °C 0.033 °C 0.038 °C	Fluke 7526A
Pt 3926, 100 Ω	(-200 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 300) °C (300 to 400) °C (400 to 630) °C	0.013 °C 0.015 °C 0.017 °C 0.022 °C 0.026 °C 0.032 °C	
Pt 3916, 100 Ω	(-200 to -190) °C (-190 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 300) °C (300 to 400) °C (400 to 600) °C (600 to 630) °C	0.01 °C 0.013 °C 0.015 °C 0.017 °C 0.022 °C 0.026 °C 0.031 °C 0.033 °C	



Parameter/Equipment	Range	CMC ² (±)	Comments
Electrical Calibration of RTDs ³ Indicating Systems & Measure – (cont)			
Pt 385, 200 Ω	(-200 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 260) °C (260 to 300) °C (300 to 400) °C (400 to 630) °C	0.053 °C 0.056 °C 0.06 °C 0.06 °C 0.069 °C 0.071 °C 0.088 °C	Fluke 7526A
Pt 385, 500 Ω	(-200 to 0) °C (0 to 100) °C (100 to 300) °C (300 to 400) °C (400 to 630) °C	0.026 °C 0.028 °C 0.034 °C 0.038 °C 0.045 °C	
Pt 385, 1000 Ω	(-200 to 0) °C (0 to 100) °C (100 to 300) °C (300 to 400) °C (400 to 630) °C	0.015 °C 0.018 °C 0.024 °C 0.026 °C 0.033 °C	
Ni 120, 120 Ω	(-80 to 260) °C	0.009 °C	
Cu 427, 10 Ω	(-100 to 260) °C	0.11 °C	
SPRT	(-200 to 660) °C	0.06 °C	
Thermocouple ³ – Indicating Systems & Measure			
Type B	(600 to 800) °C (800 to 1550) °C 1550 to 1820) °C	0.35 °C 0.28 °C 0.22 °C	Fluke 7526A
Type C	(0 to 1000) °C (1000 to 1800) °C (1800 to 2000) °C (2000 to 2316) °C	0.16 °C 0.23 °C 0.26 °C 0.35 °C	

Parameter/Equipment	Range	CMC ² (±)	Comments
Thermocouple ³ – Indicating Systems & Measure (cont)			
Type E	(-250 to -200) °C (-200 to -100) °C (-100 to 0) °C (0 to 600) °C (600 to 1000) °C	0.25 °C 0.12 °C 0.09 °C 0.08 °C 0.1 °C	Fluke 7526A
Type J	(-210 to -100) °C (-100 to 800) °C (800 to 1200) °C	0.14 °C 0.09 °C 0.1 °C	
Type K	(-250 to -200) °C (-200 to -100) °C (-100 to 500) °C (500 to 800) °C (800 to 1372) °C	0.46 °C 0.16 °C 0.1 °C 0.1 °C 0.13 °C	
Type L	(-200 to -100) °C (-100 to 900) °C	0.1 °C 0.09 °C	
Type N	(-250 to -200) °C (-200 to -100) °C (-100 to 0) °C (0 to 100) °C (100 to 800) °C (800 to 1300) °C	0.73 °C 0.23 °C 0.12 °C 0.11 °C 0.1 °C 0.12 °C	
Type R	(50 to -25) °C (-25 to 0) °C (0 to 100) °C (100 to 400) °C (400 to 600) °C (600 to 1000) °C (1000 to 1600) °C (1600 to 1767) °C	0.55 °C 0.45 °C 0.39 °C 0.28 °C 0.22 °C 0.21 °C 0.19 °C 0.23 °C	
Type S	(-50 to -25) °C (-25 to 0) °C (0 to 100) °C (100 to 400) °C (400 to 600) °C (600 to 1000) °C (1000 to 1600) °C (1600 to 1767) °C	0.51 °C 0.43 °C 0.38 °C 0.29 °C 0.23 °C 0.22 °C 0.22 °C 0.26 °C	



Parameter/Equipment	Range	CMC ^{2,5} (±)	Comments
Thermocouple ³ – Indicating Systems & Measure (cont)			
Type T	(-250 to -200) °C (-200 to -100) °C (-100 to 0) °C (0 to 200) °C (200 to 400) °C	0.35 °C 0.16 °C 0.11 °C 0.09 °C 0.09 °C	Fluke 7526A
Type U	(-200 to 0) °C (0 to 200) °C (200 to 600) °C	0.16 °C 0.1 °C 0.1 °C	
Distortion ^{3,7}	20 Hz to 20 kHz (20 to 100) kHz	1.0 dB 2.0 dB	Agilent 8903A
Oscilloscopes ^{3,7} –			
Risetime	Single Sided	<125 ps ± 12 ps	Fluke 5522A-SC1100
Bandwidth	50 kHz to 100 MHz (100 to 300) MHz (300 to 600) MHz (0.6 to 1.1) GHz	1.9 % + 0.10 mV 2.3 % + 0.10 mV 4.2 % + 0.10 mV 5.1 % + 0.10 mV	

V. Electrical – RF/Microwave

Parameter/Range	Frequency	CMC ^{2,6} (±)	Comments
Return Loss ³ (VSWR)	5 MHz to 2 GHz (2 to 12.5) GHz (12.5 to 18) GHz	0.11 dB 0.53 dB 0.85 dB	Agilent 8902A with: Wiltron 60NF50 Wiltron 58A50
Power Meter ³ – Power Reference @ 1 mW	50 MHz	1.9 %	Power transfer using Agilent 432A, 478A- H76
Power Accuracy	3 μW to 100 mW	0.29 %	Range calibrator

Parameter/Range	Frequency	CMC ^{2,5} (±)	Comments
Relative Power ³ – Measure			
(0 to -10) dB	10 MHz to 26.5 GHz	0.046 dB	Agilent 8902A
(-10 to -20) dB	10 MHz to 26.5 GHz	0.053 dB	
(-20 to -30) dB	10 MHz to 26.5 GHz	0.080 dB	
(-30 to -40) dB	10 MHz to 26.5 GHz	0.098 dB	
(-40 to -50) dB	10 MHz to 26.5 GHz	0.11 dB	
(-50 to -60) dB	10 MHz to 26.5 GHz	0.12 dB	
(-60 to -70) dB	10 MHz to 26.5 GHz	0.13 dB	
(-70 to -80) dB	10 MHz to 26.5 GHz	0.17 dB	
(-80 to -90) dB	10 MHz to 26.5 GHz	0.18 dB	
(-90 to -100) dB	10 MHz to 26.5 GHz	0.19 dB	
(-100 to -110) dB	10 MHz to 26.5 GHz	0.19 dB	
(-110 to -120) dB	10 MHz to 26.5 GHz	0.21 dB	
Absolute Power ³ – Measure			
(-70 to -30) dBm	10 MHz to 18 GHz	2.7 %	Agilent 437B/E4418B: Agilent 8484A, N-type
(-30 to +10) dBm	100 kHz to 4.2 GHz	1.4 %	Agilent 8482A, N-type Agilent 8481A, N-type Agilent 8485A, 3.5 mm
	(4.2 to 18) GHz	1.9 %	
	(18 to 26.5) GHz	2.4 %	
(+10 to +20) dBm	100 kHz to 4.2 GHz	3.3 %	Agilent 8482A, N-type Agilent 8481A, N-type Agilent 8485A, 3.5 mm
	(4.2 to 18) GHz	3.5 %	
	(18 to 26.5) GHz	3.8 %	
Amplitude Modulation ³	(20 to 50) kHz 50 kHz to 100 kHz	1.4 % 3.6 %	Agilent 8902A
Frequency Modulation ³			
Dev: Up to 400 kHz	(20 to 50) Hz	5.8 %	Agilent 8902A
	50 Hz to 100 kHz	1.4 %	
	(100 to 200) kHz	5.8 %	
Phase Modulation ³	200 Hz to 10 kHz 200 Hz to 20 kHz	4.7 % 3.5 %	Agilent 8902A

VI. Mechanical

Parameter/Equipment	Range	CMC ^{2, 6} (±)	Comments
Balances ³	1 mg to 220 g	20 µg/g	Class 3 weights
Scales ³	2 mg to 55 kg	0.020 %	Class F/6 weights
Force Gages	Up to 500 lbf	0.020 %	Class 6/F weights
Direct Verification of Durometers ³ –			
Spring Force			Precision balance
A	(0.55 to 8.05) N	0.6 points	
B	(0.55 to 8.05) N	0.6 points	
C	Up to 45.45 N	0.6 points	
D	Up to 45.45 N	0.6 points	
DO	Up to 45.45 N	0.6 points	
E	(0.55 to 8.05) N	0.6 points	
O	(0.55 to 8.05) N	0.6 points	
Indenter Shape			Optical comparator
A	35° ± 1/4°; 0.79 mm ± 0.03 mm	Pass/Fail	
B	30° ± 1/2°; 0.1 mm ± 0.012 mm	Pass/Fail	
C	35° ± 1/4°; 0.79 mm ± 0.03 mm	Pass/Fail	
D	30° ± 1/2°; 0.1 mm ± 0.012 mm	Pass/Fail	
DO	1.19 mm ± 0.05 mm	Pass/Fail	
E	2.5 mm ± 0.04 mm	Pass/Fail	
O	1.19 mm ± 0.05 mm	Pass/Fail	
Pressure Measuring Equipment & Measure –			
Pneumatic	(-12 to 300) psig	0.12 %	Fluke 700PV4 w/ 717 300G
	(0 to 15) psig	0.052 %	Fluke 7526A/725 w/ 700P04
	(1.5 to 710) psig	0.025 %	Bell & Howell CEC 6-201-001 DWT
	(10 to 10 000) psig	0.10 % + 0.052 % psi	Ametek T-41



Parameter/Equipment	Range	CMC ^{2,6} (±)	Comments
Pressure Measuring Equipment & Measure – (cont)			
Hydraulic	(0 to 30) psi (0 to 100) psi (0 to 500) psi (0 to 10 000) psi	0.05 % 0.05 % 0.06 % 0.094 %	Fluke 7526A/725 w/ 700P05 700P06 700P07 700P31
	(100 to 10 000) psi	0.12 %	Deadweight tester
Torque Wrenches	(0 to 2000) ft·lbf	0.4 %	Torque transducers
Torque Transducers	(0 to 2000) ft·lbf	0.16 %	Torque arms, weights

VII. Thermodynamic

Parameter/Equipment	Range	CMC ^{2,6} (±)	Comments
Temperature – Measuring Equipment ^{3,7}	(-78 to 100) °C (100 to 400) °C (400 to 600) °C	0.069 °C 0.082 °C 0.42 °C	Hart 1522 w/ 5609 w/ baths
Temperature ^{3,7} – Measure	(-200 to 100) °C (100 to 400) °C (400 to 670) °C Up to 1500 °F	0.043 °C 0.061 °C 0.11 °C 2.8 °F	Hart 1522 w/ 5609 Fluke 743B w/ Type K
Infrared Thermometers	(-30 to 35) °C (35 to 500) °C	0.51 °C 0.35 % + 0.5 °C	Hart 9133 black body Hart 4181 black body
Relative Humidity – Measuring Equipment	(5 to 95) % RH	1.4 % RH	Kaymont 2000
Measure	(10 to 90) % RH	1.1 % RH	Vaisala HMI41/HMP46

VIII. Time & Frequency

Parameter/Equipment	Range	CMC ² (±)	Comments
Frequency ^{3,7} – Measuring Equipment	10 MHz Reference	1.2 parts in 10 ¹⁰ MHz	Rubidium oscillator
	1 mHz to 26.5 GHz	1.2 parts in 10 ¹⁰ MHz	Rubidium oscillator and 3325B or 8340B
Frequency ^{3,7} – Measure	1 mHz to 26.5 GHz	1.2 parts in 10 ¹⁰ MHz	Rubidium oscillator locked to 53132A or 53181A

¹ This laboratory offers commercial calibration service and field calibration service.

² Calibration and Measurement Capability Uncertainty (CMC) is the smallest uncertainty of measurement that a laboratory can achieve within its scope of accreditation when performing more or less routine calibrations of nearly ideal measurement standards or nearly ideal measuring equipment. CMCs represent expanded uncertainties expressed at approximately the 95 % level of confidence, usually using a coverage factor of $k = 2$. The actual measurement uncertainty of a specific calibration performed by the laboratory may be greater than the CMC due to the behavior of the customer's device and to influences from the circumstances of the specific calibration.

³ Field calibration service is available for this calibration and this laboratory meets A2LA R104 – *General Requirements: Accreditation of Field Testing and Field Calibration Laboratories* for these calibrations. Please note the actual measurement uncertainties achievable on a customer's site can normally be expected to be larger than the CMC found on the A2LA Scope. Allowance must be made for aspects such as the environment at the place of calibration and for other possible adverse effects such as those caused by transportation of the calibration equipment. The usual allowance for the actual uncertainty introduced by the item being calibrated, (e.g. resolution) must also be considered and this, on its own, could result in the actual measurement uncertainty achievable on a customer's site being larger than the CMC.

⁴ In the statement of CMC, L is the numerical value of the nominal length of the device measured in inches; D is the length of the diagonal in inches, R is the resolution of the unit under test.

⁵ The stated measured values are determined using the indicated instrument (see Comments). This capability is suitable for the calibration of the devices intended to measure or generate the measured value in the ranges indicated. CMC's are expressed as either a specific value that covers the full range or as a percent or fraction of the reading plus a fixed floor specification.

⁶ In the statement of CMC, percentages are percentage of reading unless otherwise indicated.

⁷ Uncertainty components that can be reasonably attributed to the Unit Under Test have not been utilized in the calculation of the CMC value for this measurement parameter.

⁸ This laboratory meets R205 – *Specific Requirements: Calibration Laboratory Accreditation Program* for the types of dimensional tests listed above and is considered equivalent to that of a calibration.





Accredited Laboratory

A2LA has accredited

TRESCAL, INC.

Sparks, MD

for technical competence in the field of

Calibration

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005 *General requirements for the competence of testing and calibration laboratories*. This laboratory also meets the requirements of ANSI/NCSLI Z540-1-1994 and the requirements of ANSI/NCSLI Z540.3-2006 and R205 – Specific Requirements: Calibration Laboratory Accreditation Program. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (*refer to joint ISO-ILAC-IAF Communiqué dated April 2017*).



Presented this 31st day of July 2018.

A handwritten signature in black ink, written over a horizontal line.

President and CEO
For the Accreditation Council
Certificate Number 1346.01
Valid to December 31, 2019

For the calibrations to which this accreditation applies, please refer to the laboratory's Calibration Scope of Accreditation.